

Silicon Carbide (SiC) MOSFET - EliteSiC, 23 mohm, 650 V, M3S, TO-247-3L NTHL023N065M3S

Features

- Typical $R_{DS(on)} = 23 \text{ m}\Omega$ @ $V_{GS} = 18 \text{ V}$
- Ultra Low Gate Charge $(Q_{G(tot)} = 69 \text{ nC})$
- High Speed Switching with Low Capacitance (Coss = 153 pF)
- 100% Avalanche Tested
- This Device is Halide Free and RoHS Compliant with Exemption 7a, Pb–Free 2LI (on second level interconnection)

Applications

 SMPS, Solar Inverters, UPS, Energy Storages, EV Charging Infrastructure

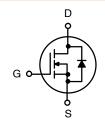
MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage		V _{DSS}	650	٧
Gate-to-Source Voltage		V _{GS}	-8/+22	V
Continuous Drain Current (Note 1)	T _C = 25°C	I _D	40	Α
Power Dissipation		P_{D}	263	W
Continuous Drain Current (Note 2)	T _C = 100°C	I _D	40	Α
Power Dissipation		P_{D}	131	W
Pulsed Drain Current (Note 3)	$T_C = 25^{\circ}C$ $t_p = 100 \ \mu s$	I _{DM}	218	Α
Continuous Source-Drain Current (Body Diode)	$T_C = 25^{\circ}C$ $V_{GS} = -3 \text{ V}$	Is	40	Α
	T _C = 100°C V _{GS} = -3 V		25	
Pulsed Source-Drain Current (Body Diode) (Note 3)	$T_C = 25^{\circ}C$ $V_{GS} = -3 V$ $t_p = 100 \ \mu s$	I _{SM}	162	Α
Single Pulse Avalanche Energy (Note 4)	I _{LPK} = 19.6 A, L = 1 mH	E _{AS}	192	mJ
Operating Junction and Storage Te Range	T _J , T _{stg}	-55 to +175	°C	
Lead Temperature for Soldering Purposes (1/8" from case for 10 seconds)		TL	270	ç

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 40 A is limited by package. Power chip max drain current is 70 A if limited by max junction temperature.
- 40 A is limited by package. Power chip max drain current is 49 A if limited by max junction temperature.
- 3. Repetitive rating, limited by max junction temperature.
- 4. E_{AS} of 192 mJ is based on starting T_J = 25°C, L = 1 mH, I_{AS} = 19.6 A, V_{DD} = 100 V, V_{GS} = 18 V

V _{(BR)DSS}	R _{DS(ON)} TYP	I _D MAX
650 V	23 m Ω @ V _{GS} = 18 V	40 A

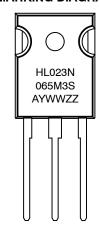


N-CHANNEL MOSFET



TO-247-3LD CASE 340CX

MARKING DIAGRAM



HL023N065M3S = Specific Device Code

A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping
NTHL023N065M3S	TO-247-3L	30 Units / Tube

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Note 5)	$R_{ heta JC}$	0.57	°C/W
Thermal Resistance, Junction-to-Ambient (Note 5)	$R_{ hetaJA}$	40	

^{5.} The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Value	Unit
Operation Values of Gate-to-Source Voltage	V_{GSop}	−5−3 +18	V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V, } I_D = 1 \text{ mA, } T_J = 25^{\circ}\text{C}$	650	_	_	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$\Delta V_{(BR)DSS}/ \Delta T_J$	I _D = 1 mA, Referenced to 25°C	_	89	-	mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 650 V, T _J = 25°C	_	-	10	μΑ
		V _{DS} = 650 V, T _J = 175°C (Note 7)	_	-	500	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{GS} = -8/+22 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±1.0	μΑ
ON CHARACTERISTICS						
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 18 V, I _D = 20 A, T _J = 25°C	-	23	33	mΩ
		V _{GS} = 18 V, I _D = 20 A, T _J = 175°C (Note 7)	_	35	-	
		V _{GS} = 15 V, I _D = 20 A, T _J = 25°C	-	29	_	1
		V _{GS} = 15 V, I _D = 20 A, T _J = 175°C (Note 7)	-	37	=	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 10 \text{ mA}, T_J = 25^{\circ}\text{C}$	2	2.8	4	V
Forward Transconductance	9 _{FS}	V _{DS} = 10 V, I _D = 20 A (Note 7)	-	14	_	S
CHARGES, CAPACITANCES & GATE	RESISTANCE					
Input Capacitance	C _{ISS}	V _{DS} = 400 V, V _{GS} = 0 V, f = 1 MHz	-	1952	_	pF
Output Capacitance	Coss	(Note 7)	-	153	_	1
Reverse Transfer Capacitance	C _{RSS}		-	13	_	
Total Gate Charge	Q _{G(TOT)}	$V_{DD} = 400 \text{ V}, I_{D} = 20 \text{ A},$	-	69	_	nC
Gate-to-Source Charge	Q_{GS}	$V_{GS} = -3/18 \text{ V (Note 7)}$	-	19	_	1
Gate-to-Drain Charge	Q_{GD}		-	18	_	1
Gate Resistance	R_{G}	f = 1 MHz	-	4.0	_	Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -3/18 \text{ V}, V_{DD} = 400 \text{ V},$	-	12	_	ns
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 20$ A, $R_G = 4.7 \Omega$, $T_J = 25$ °C (Notes 6 and 7)	_	38	_	
Rise Time	t _r		-	30	-	
Fall Time	t _f		_	11	-	
Turn-On Switching Loss	E _{ON}		-	174	_	μJ
Turn-Off Switching Loss	E _{OFF}		-	44	-]
Total Switching Loss	E _{TOT}		_	218	_	

$\textbf{ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ specified) \ (continued)$

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -3/18 \text{ V}, V_{DD} = 400 \text{ V},$	_	11	-	ns
Turn-Off Delay Time	t _{d(OFF)}	I _D = 20 A, R _G = 4.7 Ω, T _J = 175°C (Notes 6 and 7)	_	45	-	
Rise Time	t _r	,	_	29	-	
Fall Time	t _f	1	_	14	-	
Turn-On Switching Loss	E _{ON}	1	-	173	-	μJ
Turn-Off Switching Loss	E _{OFF}	1	_	64	-	
Total Switching Loss	E _{TOT}	1	_	237	-	
SOURCE-TO-DRAIN DIODE CHARACTERISTICS						
Forward Diode Voltage	V _{SD}	I _{SD} = 20 A, V _{GS} = -3 V, T _J = 25°C	_	3.9	6.0	V
		I _{SD} = 20 A, V _{GS} = -3 V, T _J = 175°C (Note 7)	-	3.6	_	
Reverse Recovery Time	t _{RR}	$V_{GS} = -3 \text{ V}, I_S = 20 \text{ A},$	-	20	-	ns
Charge Time	ta	dl/dt = 1000 A/μs, V _{DS} = 400 V, T _{.I} = 25°C (Note 7)	_	11	-	
Discharge Time	t _b]	_	9	-	
Reverse Recovery Charge	Q_{RR}	1	-	95	-	nC
Reverse Recovery Energy	E _{REC}	1	_	6.9	_	μJ
Peak Reverse Recovery Current	I _{RRM}	1	_	9.8	-	Α

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. EON/EOFF result is with body diode.

7. Defined by design, not subject to production test.

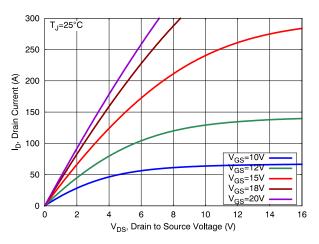


Figure 1. Output Characteristics

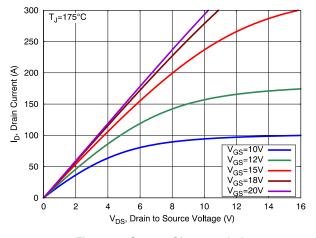


Figure 2. Output Characteristics

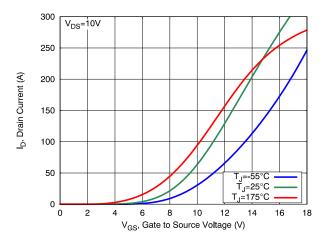


Figure 3. Transfer Characteristics

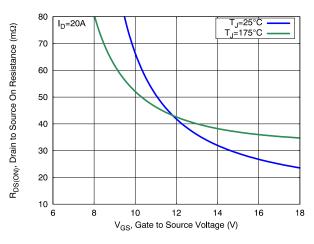


Figure 4. On-Resistance vs Gate Voltage

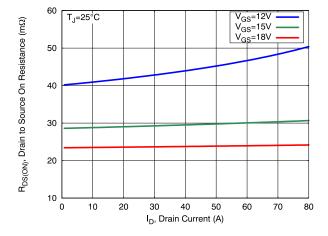


Figure 5. On-Resistance vs Drain Current

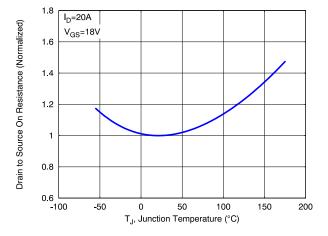


Figure 6. On–Resistance vs Junction Temperature

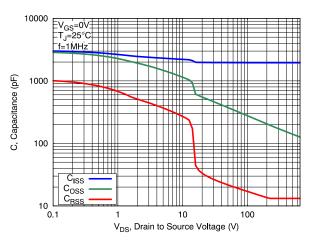


Figure 7. Capacitance Characteristics

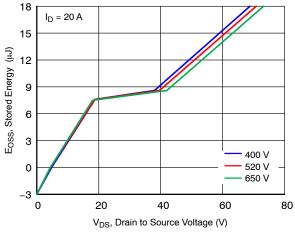


Figure 9. Gate Charge Characteristics

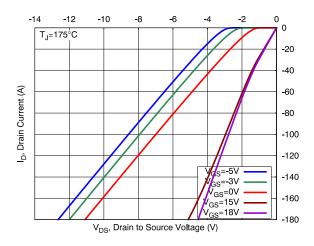


Figure 11. Reverse Conduction Characteristics

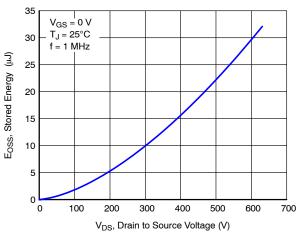


Figure 8. Stored Energy vs Drain to Source Voltage

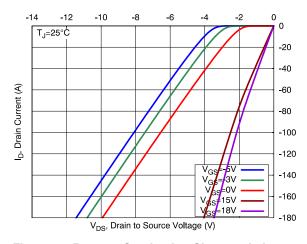


Figure 10. Reverse Conduction Characteristics

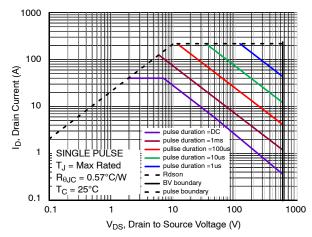


Figure 12. Safe Operating Area

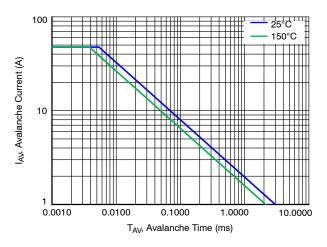


Figure 13. Avalanche Current vs Pulse Time (UIS)

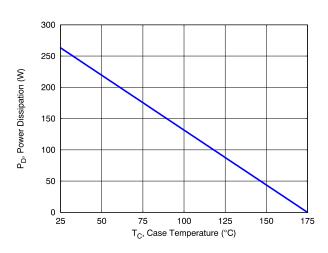


Figure 14. Maximum Power Dissipation vs
Case Temperature

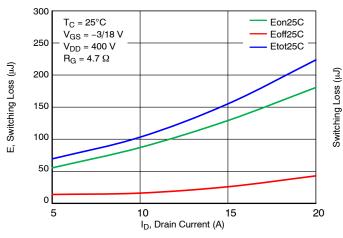


Figure 15. Inductive Switching Loss vs Drain Current

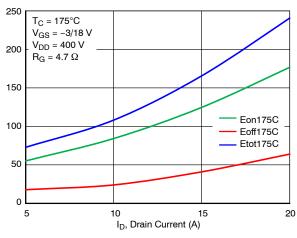


Figure 16. Inductive Switching Loss vs Drain Current

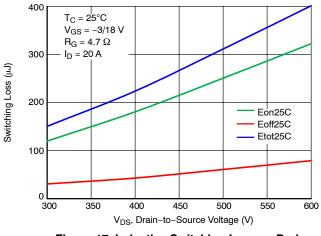


Figure 17. Inductive Switching Loss vs Drain Voltage

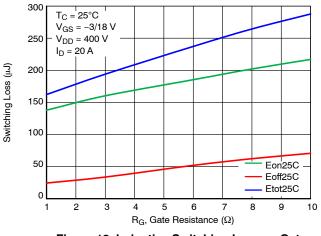


Figure 18. Inductive Switching Loss vs Gate Resistance

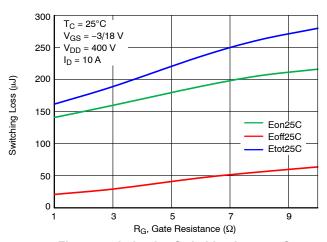


Figure 19. Inductive Switching Loss vs Gate Resistance

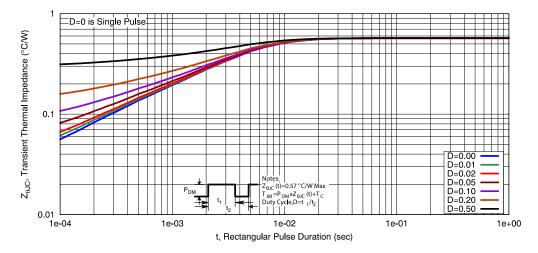
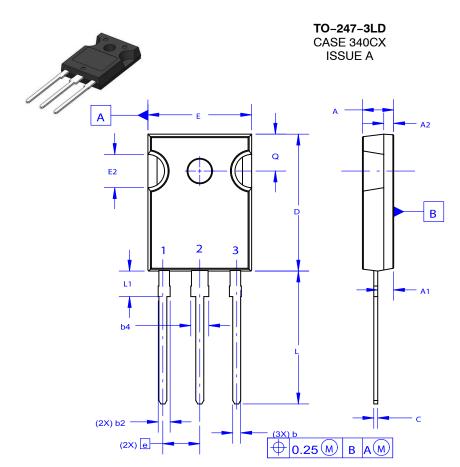
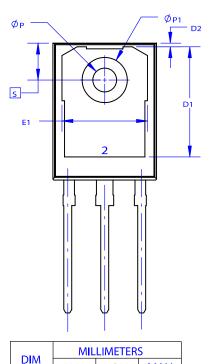


Figure 20. Thermal Response Characteristics



DATE 06 JUL 2020



NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM* Description: Des



XXXXX = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

MILLIMETERS		
MIN	NOM	MAX
4.58	4.70	4.82
2.20	2.40	2.60
1.40	1.50	1.60
20.32	20.57	20.82
15.37	15.62	15.87
4.96	5.08	5.20
~	5.56	~
19.75	20.00	20.25
3.69	3.81	3.93
3.51	3.58	3.65
5.34	5.46	5.58
5.34	5.46	5.58
1.17	1.26	1.35
1.53	1.65	1.77
2.42	2.54	2.66
0.51	0.61	0.71
13.08	~	~
0.51	0.93	1.35
12.81	~	~
6.60	6.80	7.00
	MIN 4.58 2.20 1.40 20.32 15.37 4.96 ~ 19.75 3.69 3.51 5.34 5.34 1.17 1.53 2.42 0.51 13.08 0.51 12.81	MIN NOM 4.58 4.70 2.20 2.40 1.40 1.50 20.32 20.57 15.37 15.62 4.96 5.08 ~ 5.56 19.75 20.00 3.69 3.81 3.51 3.58 5.34 5.46 5.34 5.46 1.17 1.26 1.53 1.65 2.42 2.54 0.51 0.61 13.08 ~ 0.51 0.93 12.81 ~

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C3M0045065K E3M0120090J C3M0065090J-TR C3M0120100J C3M0075120J DMWS120H100SM4 DMWSH120H28SM4
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DMWSH120H43SM3 DMWSH120H90SM3 DMWSH120H28SM3Q DMWSH120H90SM3Q DIF120SIC053-AQ DIW120SIC059-AQ
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